

		Data Sl	heet		
Custome	r:				
Product: available		m Electrolytic C	apacitors – AE5R Ser	ies AEC-Q200	version_
<u>Size : 4x</u>	5mm ~ 8	x5mm			
Issued D	ate: 16-0	oct-2023			
Edition:	Ver. 1				
		Record	l of change		
Date	Ver.		Description		Page
16-Oct-2023	1				
HITANO E					1
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Prepared by		Checked by	Approved by	Accepted by	(customer)
16-Oct-2023		16-Oct-2023	16-Oct-2023		
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• Ultra miniature Radial Type 5mm Height

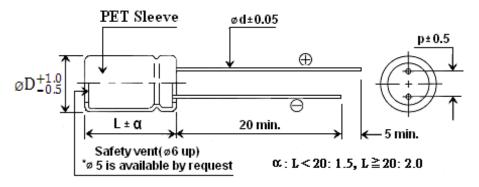
• Designed for use in VCRs, car radios, Car stereos.

• AEC-Q200 version available

Characteristics

Voltage Range			4 ~ 50	V							
Capacitance Range		0.1 ~ 220uF									
Temperature Range	-40 ~ + 105°C										
Capacitance Tolerance	±20% at 1	$\pm 20\%$ at 120Hz , 20°C(10% Tol. is available upon request)									
Leakage Current	I≤0.010	I≤0.01CV or 3uA, whichever is greater (After 2 minutes)									
Dissipation Factor	Rated Voltage (V)	4V	6.3V	10V	16V	25V	35V	50V			
	Dissipation Factor(tan d)max	x 0.35	0.24	0.20	0.16	0.14	0.12	0.10			
		1	1				(at 20°C,	120Hz)			
Stability at Low Temperature	Impedance ration at 120Hz										
	Rated Voltage (V)	4V	6.3V	10V	16V	25V	35V	50V			
	Z-25°C/Z 20°C	7	4	3	2	2	2	2			
	Z-40°C/Z 20°C	15	8	6	4	4	3	3			
Load Life	After the rated voltage has	Within	Within ±20% of initial value								
(size 8x5mm is 85°C 1000hrs)	been applied for 1000 hours at 105°C	D.F. tand		200%	or less of i	of initial specified value					
	Leakage current Less than Initial sp										
Shelf Life (size 8x5mm is 85°C 500hrs)	After storage for 1000 hours specified limit in load life. Pr										
	DC working voltage for 30 m	ninutes.									

Diagram of dimensions



D§	4	5	6.3	8					
р	1.5	2.0	2.5	3.5					
d §	0.45								

Ripple Current Coefficients

Frequency (Hz)	50(60)	120	1K	≥10K					
Cap.(uF) / Hz	Multiplier								
Cap. ≦ 10	0.65	1.0	1.30	1.50					
10 <cap.≦100< th=""><th>0.8</th><th>1.0</th><th>1.15</th><th>1.20</th></cap.≦100<>	0.8	1.0	1.15	1.20					



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Cap. WV	4	4 6.3		4 6.3 10 16		6.3 10 16		2	5	35		50		
uF	Size	R.C.	Size	R.C.	Size	R.C.	Size	R.C.	Size	R.C.	Size	R.C.	Size	R.C.
0.1												\rightarrow	4x5	1.0
0.22												\rightarrow	4x5	2.0
0.33												\rightarrow	4x5	2.8
0.47		ALL BI	ANK VC	TAGE (N SI FEV	VE MARF	ZING IS S	AME VO	TAGE			\rightarrow	4x5	4.0
1		ALL DI		LINGL		DINT TO		ANL VO	LIAOL			\rightarrow	4x5	8.0
2.2												\rightarrow	4x5	10
3.3												\rightarrow	4x5	17
4.7								\rightarrow	4x5	16	4x5	18	5x5	20
10						\rightarrow	4x5	23	4x5	27	5x5	30	6.3x5	33
22					4x5	28	5x5	37	5x5	42	6.3x5	46	6.3x5	48
33		\rightarrow	\rightarrow	\rightarrow	5x5	41	5x5	49	6.3x5	53	8x5	62		
47	4x5	34	5x5	45	5x5	45	6.3x5	58	6.3x5	60	8x5	80		
100	5x5	50	6.3x5	56	6.3x5	70	6.3x5	85	8x5	95				
220	6.3x5	80	6.3x5	90	8x5	95								

Part Numbering System

T1 AE5R Μ 25 101 Α **SERIES** CAPACITANCE TOL. W.V. PACKAGE SIZE LEAD SPACE **IN 3DIGITS** $K=\pm 10\%$ 0G = 4VB= Bulk Omit if only Omit if Bulk 010 = 1.0 uF $M=\pm 20\%$ 0J= 6.3V C5= Cut 5mm one size T1 = L/S 2.5mm Taped 4R7= 4.7 uF 10= 10V A= Ammo Pack A=Smaller TA= Lead forming space 5mm Taped $101 = 100 \mu F$ 25 = 25VR= Tape&Reel size 221 = 220 uF50= 50V T35= L/S 3.5mm Taped F5= Lead formed T2=L/S 5mm Taped & cut 5mm





Reliability for Car- Tronics

AEC Q-200_REV D

Endurance Characteristic:

No.	ltem		Conditions		pecification	Reference		
				Capacitance	Within ±30% of initial			
				change	value	MIL-STD-		
4	High	Capacitor is placed in	n the highest temperature with	Tanδ	Less than 300% of	202		
1	Temperature Load Life Test	rated voltage for 500		Lookago	specified value	Method		
	Loau Life fest			Leakage Current	Within specified value	108		
				Appearance	No abnormality			
				Capacitance	Within ±30% of initial			
	Llink			change	value	MIL-STD-		
	Temperature	ligh emperature Capacitor is placed in the highest t		Tanδ	Less than 300% of	202		
2	2 Exposure (Storage)	1000+48/-0Hrs.	in the highest temperature for		specified value	Method1		
				Leakage Current	Within specified value	08		
				Appearance	No abnormality			
				Capacitance	Within ±10% of initial			
		Step1: Max. rated te	mperature±3/-3°C(30±3mins)	change	value			
3	Temperature		nperature±3/-3°C(30±3mins)	Tan δ	Within specified value	JESD22 Method		
5	Cycling	Max.transfer time: 1		Leakage	Within specified value	JA-104		
		According to the ste	p1 to step2, and do 1000cycles	Current	-	577 104		
				Appearance	No abnormality			
				Capacitance change	Within ±20% of initial value			
		Capacitor is placed a	it the temperature of 85±3℃,		Less than 150% of	MIL-STD-		
4	Biased		5 with rated voltage for	Tanδ	specified value	202		
	Humidity	1000Hrs	0	Leakage	Within specified value	Method 103		
				Current	-	105		
				Appearance	No abnormality	JESD22		
5	Physical			Appearance	No abnormality	Method		
5	Dimension			, appearance	i to abriotritaity	JB-100		
			be immersed into the		·	MIL-STD-		
	Resistance To	isopropyl.			202			
6	Solvent		+0.5/-0 minutes at 25±5°C.	Print cannot f	Method			
		Conduct the steps 1	brush capacitor for 10 times. \sim 3 for 3 cycles		215			
		Capacitor is placed of			Within ±10% of initial			
				Capacitance	$\frac{1}{1000}$			
		fixed.Conditions as k		Capacitance change	value			
		fixed.Conditions as k	oelow: For automobile	change Tanδ Leakage	value Within specified value			
	Mashanical	fixed.Conditions as b Test items Acceleration speed	pelow:	change Tanδ	value	MIL-STD-		
7	Mechanical	fixed.Conditions as b Test items Acceleration speed Shocking	oelow: For automobile	change Tanδ Leakage	value Within specified value	202		
7	Mechanical Shock	fixed.Conditions as b Test items Acceleration speed Shocking direction	For automobile 100g(1000 m/s ²) X-Y-Z three axles (6 planes)	change Tanδ Leakage	value Within specified value			
7		fixed.Conditions as b Test items Acceleration speed Shocking direction Duration(D)(ms)	For automobile 100g(1000 m/s ²) X-Y-Z three axles (6 planes) 6	change Tanδ Leakage	value Within specified value	202 Method		
7		fixed.Conditions as b Test items Acceleration speed Shocking direction Duration(D)(ms) Velocity(m/s)	Pelow: For automobile 100g(1000 m/s ²) X-Y-Z three axles (6 planes) 6 3.75	change Tanδ Leakage Current	value Within specified value Within specified value	202 Method		
7		fixed.Conditions as b Test items Acceleration speed Shocking direction Duration(D)(ms) Velocity(m/s) Wave	For automobile 100g(1000 m/s ²) X-Y-Z three axles (6 planes) 6 3.75 Half sine	change Tanδ Leakage Current	value Within specified value Within specified value	202 Method		
7		fixed.Conditions as b Test items Acceleration speed Shocking direction Duration(D)(ms) Velocity(m/s)	Pelow: For automobile 100g(1000 m/s ²) X-Y-Z three axles (6 planes) 6 3.75	change Tanδ Leakage Current Appearance	value Within specified value Within specified value No abnormality	202 Method		
7		fixed.Conditions as b Test items Acceleration speed Shocking direction Duration(D)(ms) Velocity(m/s) Wave Test times	Pelow: For automobile 100g(1000 m/s ²) X-Y-Z three axles (6 planes) 6 3.75 Half sine 18times (3*6=18)	change Tanδ Leakage Current Appearance Capacitance	value Within specified value Within specified value No abnormality Within ±10% of initial	202 Method 213		
7		fixed.Conditions as b Test items Acceleration speed Shocking direction Duration(D)(ms) Velocity(m/s) Wave Test times Capacitor is placed i	For automobile 100g(1000 m/s ²) X-Y-Z three axles (6 planes) 6 3.75 Half sine 18times (3*6=18) n the PCB and fixed. Setting	change Tanδ Leakage Current Appearance	value Within specified value Within specified value No abnormality	202 Method 213 MIL-STD-		
7		fixed.Conditions as b Test items Acceleration speed Shocking direction Duration(D)(ms) Velocity(m/s) Wave Test times Capacitor is placed i the acceleration (5g)	Pelow: For automobile 100g(1000 m/s ²) X-Y-Z three axles (6 planes) 6 3.75 Half sine 18times (3*6=18) n the PCB and fixed. Setting and frequency (10-2000Hz)	change Tanδ Leakage Current Appearance Capacitance change Tan δ Leakage	value Within specified value Within specified value No abnormality Within ±10% of initial value Within specified value	202 Method 213 MIL-STD- 202		
	Shock	fixed.Conditions as b Test items Acceleration speed Shocking direction Duration(D)(ms) Velocity(m/s) Wave Test times Capacitor is placed i the acceleration (5g)	Pelow: For automobile 100g(1000 m/s ²) X-Y-Z three axles (6 planes) 6 3.75 Half sine 18times (3*6=18) n the PCB and fixed. Setting and frequency (10-2000Hz) c condition ,vibration 4Hrs from	change Tanδ Leakage Current Appearance Capacitance change Tan δ	value Within specified value Within specified value No abnormality Within ±10% of initial value	202 Method 213 MIL-STD-		



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No.	Item		Conditions			Spe	ecificatio	on	Refere nce
		test twice.	e Control standard operatir	ng of Jarso	on,	Capacitance change	initia	in ±10% of I value	
						Tanδ	Withi value	in specified	
		Temperature(C)	t1 t2			Leakage Current	Withi value	in specified	
	Resistance to		т	ime(sec)		Appearance	No al	bnormality	MIL-ST D- 202
9	Soldering Heat	Rated voltage	00	4~	50	63 up	1	100	Metho
	Tieat	Case size (ϕ)	(V)	4~		4~6.3		12.5	d 210
			Temp.(T1~T2,°C)	4.00	0.5	150-180	0.4	12.5	
		Preheat	Time (t1)(Max,secs)			100			
			Temp.(T3,°C)	217	230	1	217	230	
		Duration	Time (t2)(Max,secs)	90	60	60	60	40	
			Temp.(T4,°C)	26		250		50	
		Peak	Time (t3,secs)			5			
		Reflow cycles	- (2 or less			
		, ,							
10	Solderability test (SMD)	Duration:5±0/-0	Solderability test 1: Solder bath temperature: 235±5°CSn is more than 95% in the surfaceDuration:5±0/-0.5sSn is more than 95% in the surfaceSolderability test 2:Solderbath temperature:260±5°CDuration:7±0 5cof terminal						
11	Electrical Characterizati on	Whether there is abnormality about electrical characterization in the test that under the ensurance temperature(the lowest ,the highest, atmospheric temperature).							User Spec.
						Capacitance change	initia	in ±10% of I value	
12	Board Flex	Capacitor is plac		Tanδ	Withi value	in specified	AEC-Q 200-		
		from Original fu	lcrum more than 2mm for	S.	Leakage Current	Withi value	in specified	005	
					Appearance	No abnormality			
				6 1 1		Capacitance change		in ±10% of I value	
13	Terminal Strength	paste and do hi	Capacitor is placed in the Po gh temperature test (Reflow	w) to	der	Tanδ Within specified value		AEC-Q 200-	
	(SMD)	endurance the p condition.	oower of 1.8kg for 60S,no d	lropping		Leakage Current	Within specified value		006
						Appearance		bnormality	-
			ced at 15°C~35°C with surg	-		Capacitance change	With	in ±20% of l value	
14		30±5(charging) test continuity f Applying voltag		surge volt	age	Tanð		than 175% ecified	AEC-Q 200-
14	Surge Voltage		10 16 25 35 11.5 18.4 28.8 40.3 100 160 200 250	1	63 72.5	Leakage Current	Withi value	in specified	007
			100 160 200 250 115 184 230 288		450 495	Appearance	No al	bnormality	